

FQB12N60 / FQI12N60

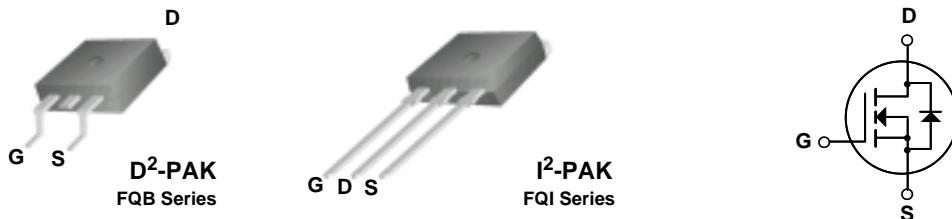
600V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

Features

- 10.5A, 600V, $R_{DS(on)} = 0.7 \Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 42 nC)
- Low C_{rss} (typical 25 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	FQB12N60 / FQI12N60	Units
V_{DSS}	Drain-Source Voltage	600	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	10.5	A
	- Continuous ($T_C = 100^\circ\text{C}$)	6.7	A
I_{DM}	Drain Current - Pulsed	(Note 1)	A
V_{GSS}	Gate-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	mJ
I_{AR}	Avalanche Current	(Note 1)	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	V
P_D	Power Dissipation ($T_A = 25^\circ\text{C}$) *	3.13	W
	Power Dissipation ($T_C = 25^\circ\text{C}$)	180	W
	- Derate above 25°C	1.43	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typ	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	--	0.7	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	--	40	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	--	62.5	$^\circ\text{C}/\text{W}$

* When mounted on the minimum pad size recommended (PCB Mount)

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C	--	0.71	--	V/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 600 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	10	μA
		$V_{\text{DS}} = 480 \text{ V}, T_C = 125^\circ\text{C}$	--	--	100	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	3.0	--	5.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 5.3 \text{ A}$	--	0.55	0.7	Ω
g_{FS}	Forward Transconductance	$V_{\text{DS}} = 50 \text{ V}, I_D = 5.3 \text{ A}$ (Note 4)	--	10	--	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	1480	1900	pF
C_{oss}	Output Capacitance		--	200	270	pF
C_{rss}	Reverse Transfer Capacitance		--	25	35	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 300 \text{ V}, I_D = 12 \text{ A}, R_G = 25 \Omega$ (Note 4, 5)	--	30	70	ns
t_r	Turn-On Rise Time		--	115	240	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	95	200	ns
t_f	Turn-Off Fall Time		--	85	180	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 480 \text{ V}, I_D = 12 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	42	54	nC
Q_{gs}	Gate-Source Charge		--	8.6	--	nC
Q_{gd}	Gate-Drain Charge		--	21	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	10.5	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	42	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_S = 10.5 \text{ A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_S = 12 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}$	--	380	--	ns
Q_{rr}	Reverse Recovery Charge		--	3.5	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 13\text{mH}$, $I_{\text{AS}} = 10.5\text{A}$, $V_{\text{DD}} = 50\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{\text{SP}} \leq 12\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{\text{DP}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

FQB12N60 / FQI12N60

Typical Characteristics

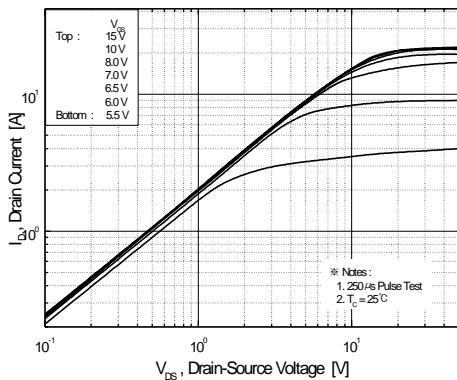


Figure 1. On-Region Characteristics

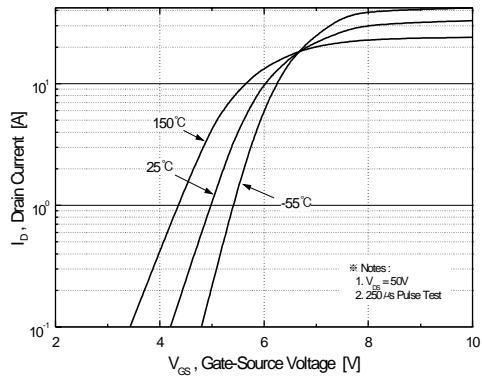


Figure 2. Transfer Characteristics

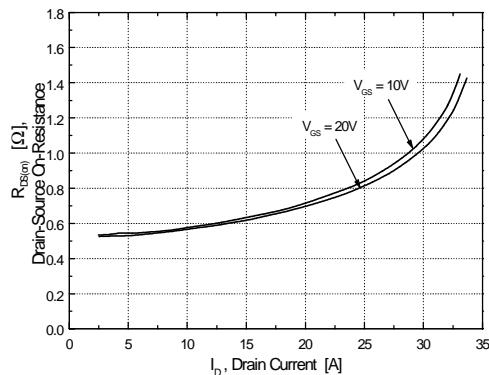


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

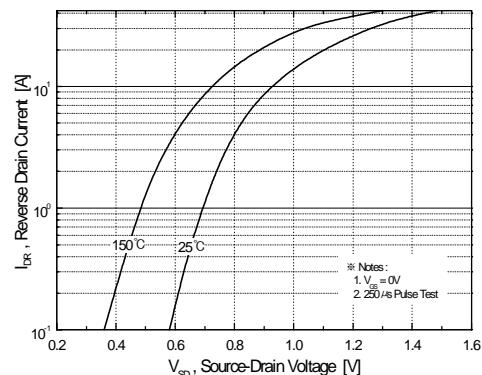


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

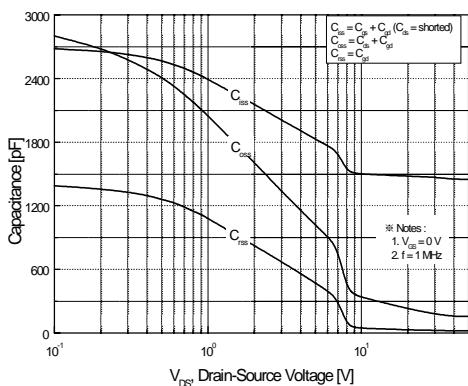


Figure 5. Capacitance Characteristics

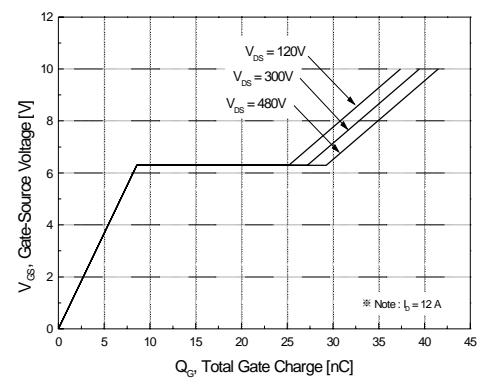


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

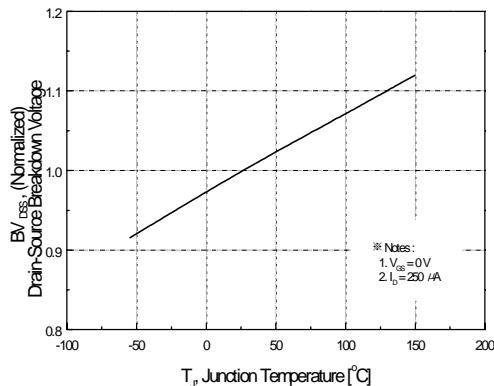


Figure 7. Breakdown Voltage Variation vs. Temperature

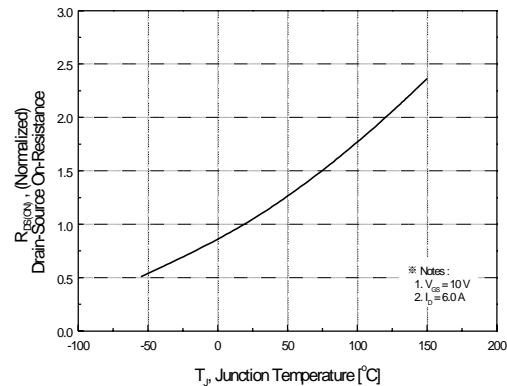


Figure 8. On-Resistance Variation vs. Temperature

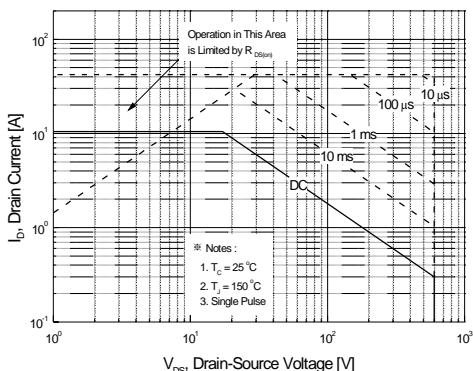


Figure 9. Maximum Safe Operating Area

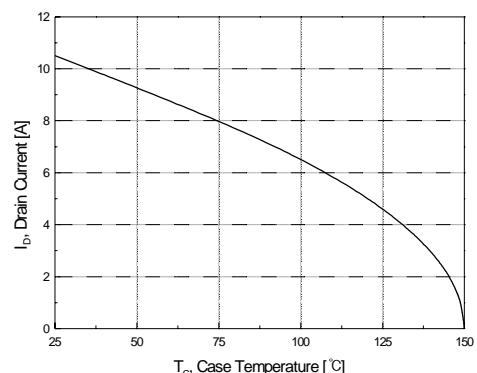


Figure 10. Maximum Drain Current vs. Case Temperature

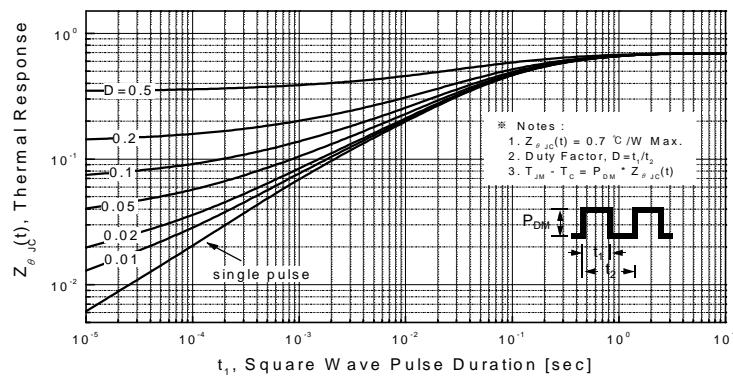
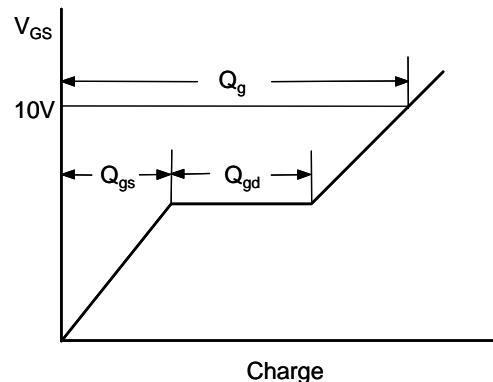
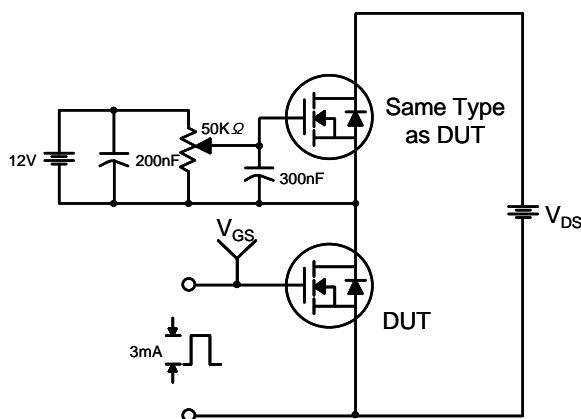
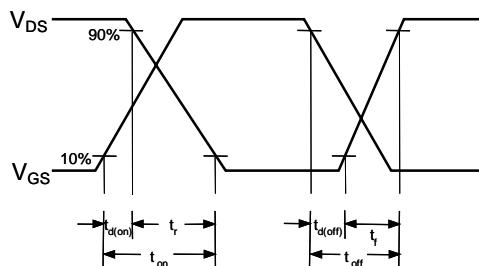
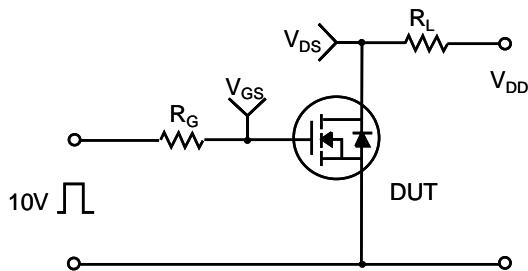


Figure 11. Transient Thermal Response Curve

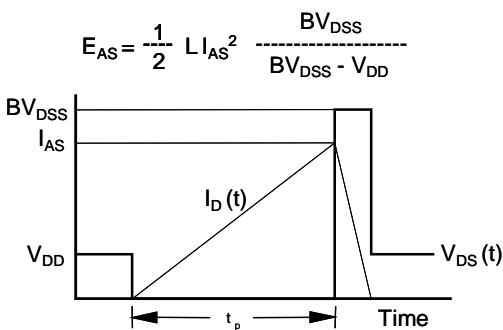
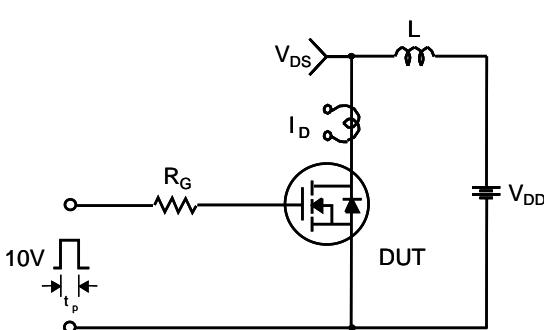
Gate Charge Test Circuit & Waveform



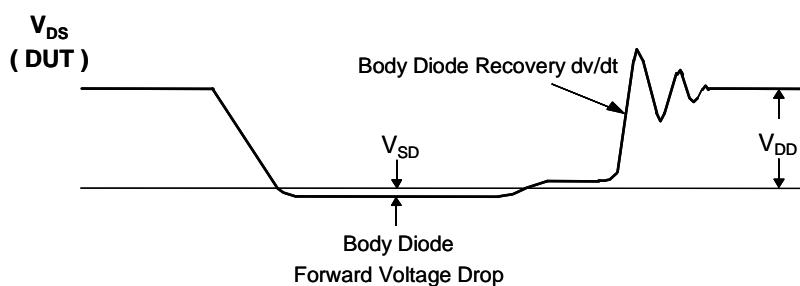
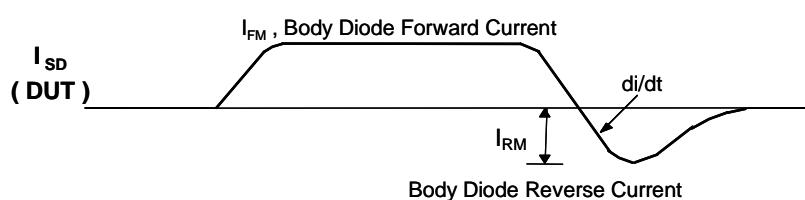
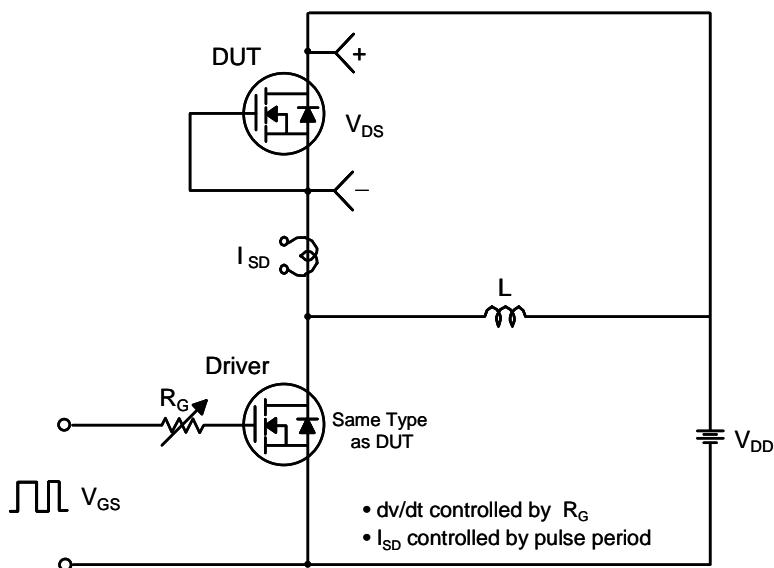
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



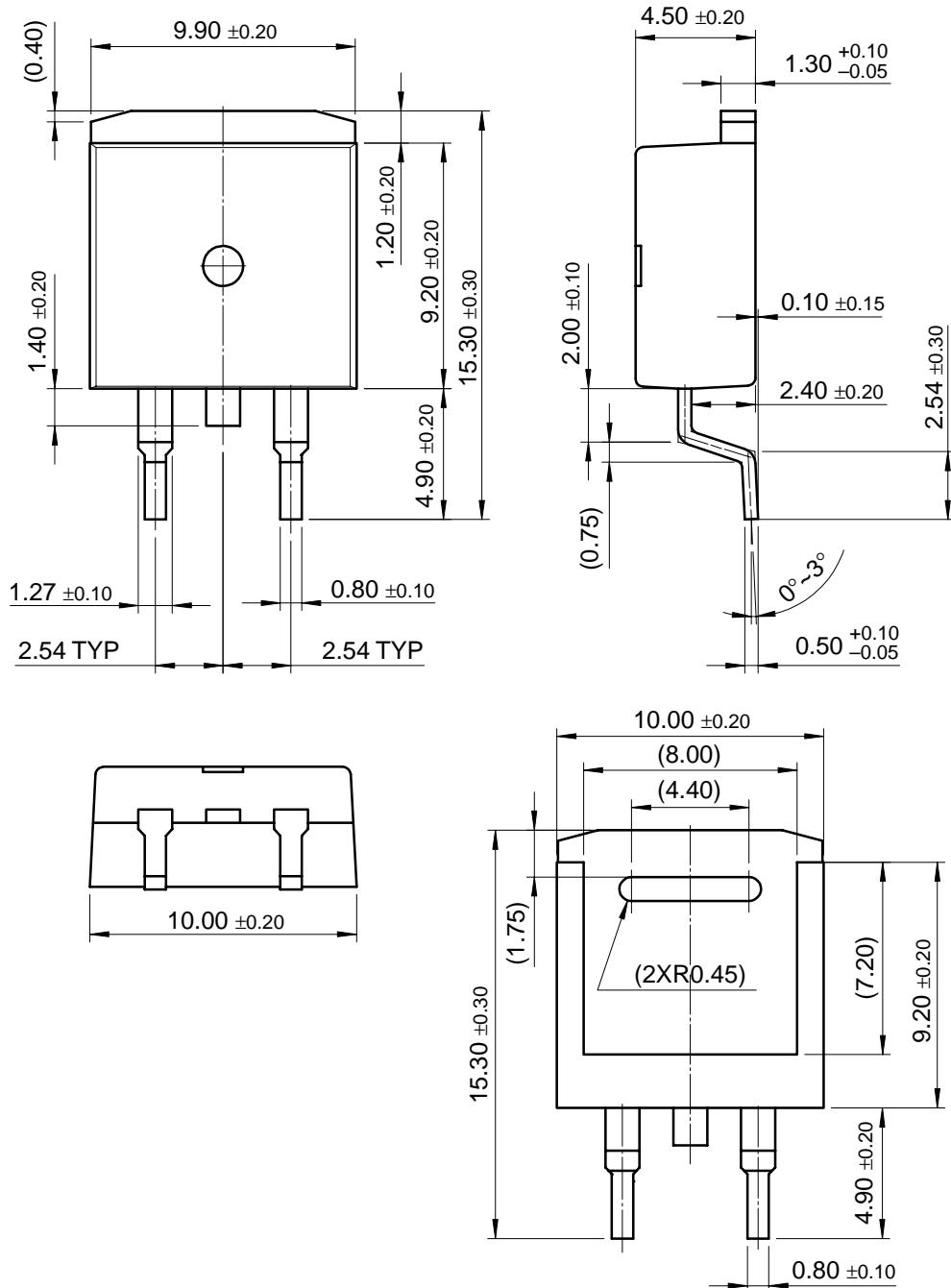
Peak Diode Recovery dv/dt Test Circuit & Waveforms



FQB12N60 / FQI12N60

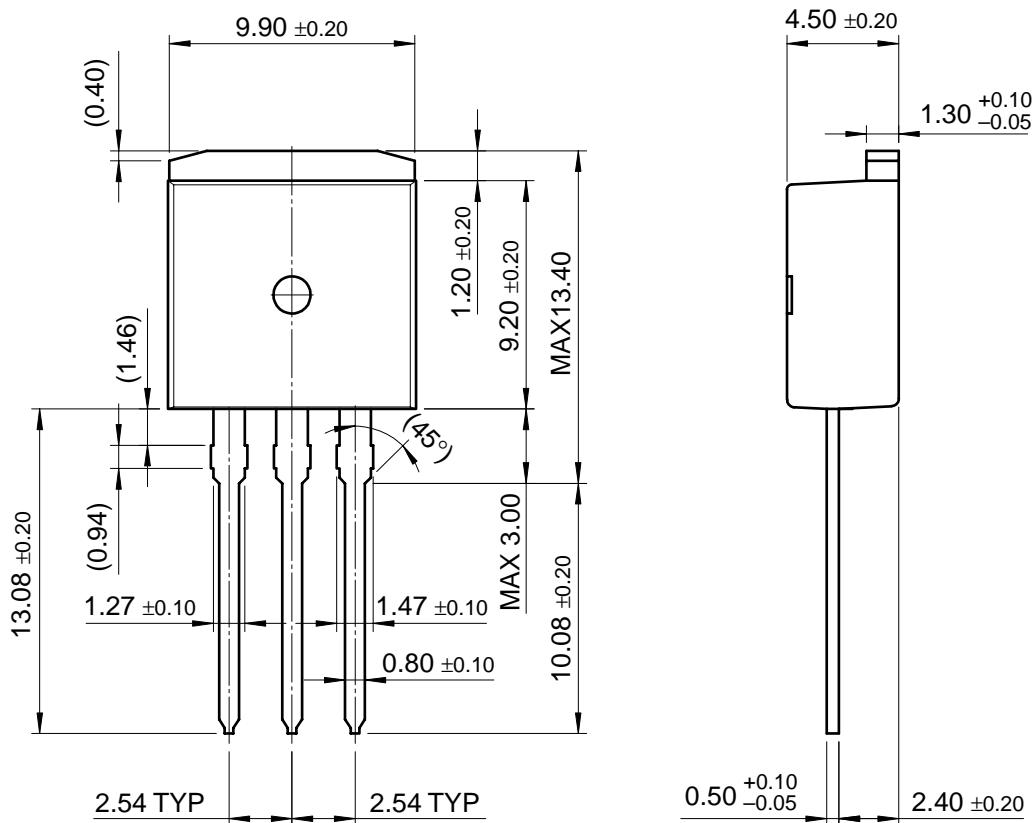
Package Dimensions

D²PAK



Package Dimensions (Continued)

I²PAK



TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACE TM	HiSeC TM	SuperSOT TM -8
Bottomless TM	ISOPLANAR TM	SyncFET TM
CoolFET TM	MICROWIRE TM	TinyLogic TM
CROSSVOLT TM	POP TM	UHC TM
E ² CMOS TM	PowerTrench [®]	VCX TM
FACT TM	QFET TM	
FACT Quiet Series TM	QS TM	
FAST [®]	Quiet Series TM	
FASTR TM	SuperSOT TM -3	
GTO TM	SuperSOT TM -6	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR INTERNATIONAL.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to

result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

find products

[Products groups](#)[Analog and Mixed](#)[Signal](#)[Discrete](#)[Interface](#)[Logic](#)[Microcontrollers](#)[Non-Volatile](#)[Memory](#)[Optoelectronics](#)[Markets and](#)[applications](#)[New products](#)[Product selection and
parametric search](#)[Cross-reference
search](#)[technical information](#)[buy products](#)[technical support](#)[my Fairchild](#)[company](#)[Home >> Find products >>](#)

FQB12N60

600V N-Channel QFET

Contents

[General description](#) | [Features](#) | [Product
status/pricing/packaging](#) | [Models](#)

General description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

[back to top](#)

Features

- 10.5A, 600V, $R_{DS(on)} = 0.7\Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 42 nC)
- Low Crss (typical 25 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

[back to top](#)

Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQB12N60TM	Full Production	\$1.90	TO-263(D2PAK)	2	TAPE REEL

* 1,000 piece Budgetary Pricing

Related Links

[Request samples](#)[Dotted line](#)[How to order products](#)[Dotted line](#)[Product Change Notices](#)[\(PCNs\)](#)[Dotted line](#)[Support](#)[Dotted line](#)[Distributor and field sales
representatives](#)[Dotted line](#)[Quality and reliability](#)[Dotted line](#)[Design tools](#)

[back to top](#)

Models

Package & leads	Condition	Temperature range	Software version	Revision date
PSPICE				
TO-263(D2PAK)-2	Electrical/Thermal	-55°C to 150°C	9.2	Apr 24, 2001

[back to top](#)

[Home](#) | [Find products](#) | [Technical information](#) | [Buy products](#) |
[Support](#) | [Company](#) | [Contact us](#) | [Site index](#) | [Privacy policy](#)

[© Copyright 2002 Fairchild Semiconductor](#)

find products

[Products groups](#)[Analog and Mixed](#)[Signal](#)[Discrete](#)[Interface](#)[Logic](#)[Microcontrollers](#)[Non-Volatile](#)[Memory](#)[Optoelectronics](#)[Markets and](#)[applications](#)[New products](#)[Product selection and](#)[parametric search](#)[Cross-reference](#)[search](#)[technical information](#)[buy products](#)[technical support](#)[my Fairchild](#)[company](#)[Home](#) >> [Find products](#) >>

FQI12N60

600V N-Channel QFET

Contents

[General description](#) | [Features](#) | [Product status/pricing/packaging](#) | [Models](#)

General description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

[back to top](#)

Features

- 10.5A, 600V, $R_{DS(on)} = 0.7\Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 42 nC)
- Low Crss (typical 25 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

[back to top](#)

Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQI12N60TU	Full Production	\$1.90	TO-262(I2PAK)	3	RAIL

* 1,000 piece Budgetary Pricing

Related Links

[Request samples](#)[Dotted line](#)[How to order products](#)[Dotted line](#)[Product Change Notices](#)[\(PCNs\)](#)[Dotted line](#)[Support](#)[Dotted line](#)[Distributor and field sales representatives](#)[Dotted line](#)[Quality and reliability](#)[Dotted line](#)[Design tools](#)

[back to top](#)

Models

Package & leads	Condition	Temperature range	Software version	Revision date
PSPICE				
TO-262(I2PAK)-3	Electrical/Thermal	-55°C to 150°C	9.2	Apr 24, 2001

[back to top](#)

[Home](#) | [Find products](#) | [Technical information](#) | [Buy products](#) |
[Support](#) | [Company](#) | [Contact us](#) | [Site index](#) | [Privacy policy](#)

[© Copyright 2002 Fairchild Semiconductor](#)

► [Find Products](#)

[Products](#)

[Analog and Mixed](#)

[Signal](#)

[Discrete](#)

[Interface & Logic](#)

[Microcontrollers](#)

[Non-Volatile](#)

[Memory](#)

[Optoelectronics](#)

[Power](#)

[Markets and](#)

[applications](#)

[New products](#)

[Product selection](#)

[and parametric](#)

[search](#)

[Cross-reference](#)

[search](#)

► [Technical Information](#)

► [Buy Products](#)

► [Support](#)

► [My Fairchild](#)

► [Global Fairchild](#)

► [Company](#)

[Home](#) >> [Product selection and parametric search](#) >> [Discrete](#) >> [MOSFET](#)

Product Summary

FQB12N60

600V N-Channel QFET

- [Download datasheet for FQB12N60](#)
- [View other related information for this product \(Product folder\)](#)

Attribute	Value	UOM
Package	TO-263(D2PAK)	
Lead Count	2	
Configuration	Single	
Polarity	N	
V _{DS}	600	V
R _{DS(ON)} Max @ V _{GS} = 10V	.7	Ohms
Q _G (Note)	42	nC
I _D	10.5	A
P _D	180	W
Device Grade	Commercial	
Lead Free	Yes	

When using the information presented in Fairchild Semiconductor's parametric search tool, we recommend that you completely review our datasheets to confirm the device functionality and performance for your application. Fairchild Semiconductor is not responsible for any incorrect or incomplete information. No information provided herein shall be used in a manner which is adverse to Fairchild.

[Home](#) | [Find products](#) | [Technical information](#) | [Buy products](#) | [Support](#) |
[Company](#) | [Contact us](#) | [Site index](#) | [Privacy policy](#) | [Site Terms & Conditions](#)

© Copyright 2003 Fairchild Semiconductor

Related links

[Product folder for FQB12N60](#)

[Request samples](#)

[How to order products](#)

[Product change notices \(PCNs\)](#)

[Support](#)

[Distributor and field sales representatives](#)

[Quality and reliability](#)

[Models and simulation tools](#)